MT4914

Dual N-Ch PowerTrench® MOSFET

General Description

The MT4914 is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC/DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. MT4914 contains two unique 30V N-ch, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using MOS-TECH's monolithic SyncFET technology.

Features

 Q1 30V/8.5A Optimized for low switching losses Low Gate Charge (11nC typical)

 $R_{DS(on)} = 18m\Omega @ V_{GS} = 10V$

 $R_{DS(on)} = 25m\Omega @ V_{GS} = 4.5V$

- Q2 30V/8.5A
 - Optimized to minimize conduction losses includes SyncFET Schottky body diode $R_{DS(on)} = 18m_{\Omega} \odot V_{GS} = 10V$

 $R_{DS(on)} = 25m \Omega @ V_{GS} = 4.5V$

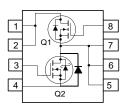
- 100%R_G (Gate Resistance) Tested
- RoHS Compliant

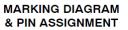
Absolute Maximum Ratings ($T_A = 25^{\circ}C$ unless otherwise noted)

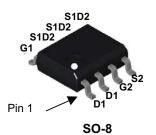


http://www.mtsemi.com

Simplified Schematic







Symbol	Parameter		Q2	Q1	Units
V _{DSS}	Drain-Source Voltage		30	30	V
V _{GSS}	Gate-Source Voltage		±20	±20	V
1	Drain Current - Continuous	(Note 1a)	8.5	8.5	
I _D	- Pulsed		30	30	A
	Power Dissipation for Dual Operation		2		_
Po	Power Dissipation for Single Operation (Note 1a) (Note 1b) (Note 1c)		1.6		
гD			1		W
			0.		
T _J , T _{STG}	Operating and Storage Junction Temperat	ure Range	–55 to	+150	°C
hermal	Characteristics	÷			
_				-	

R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

Device Marki	ng Device	Device Reel Size Tape width		Quantity
MT4914	MT491	4 13"	12mm	2500 units

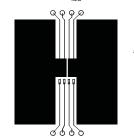
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Off Char	acteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 1 mA$ $V_{GS} = 0 V$, $I_D = 250 uA$	Q2 Q1	30 30			V
	Breakdown Voltage	I_D = 10 mA, Referenced to 25°C	Q2	50	27		mV/°C
ΔΤ,	Temperature Coefficient Zero Gate Voltage Drain	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C $V_{DS} = 24 \ \text{V}$, $V_{GS} = 0 \ \text{V}$	Q1 Q2		22	500	
I _{DSS}	Current		Q1			1	μA
I _{GSS}	Gate-Body Leakage	V_{GS} = ±20 V, V_{DS} = 0 V	Q2 Q1			±100	nA
On Char	acteristics (Note 2)				_		
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$ \begin{array}{ll} V_{\text{DS}} = V_{\text{GS}}, & I_{\text{D}} = 1 \text{ mA} \\ V_{\text{DS}} = V_{\text{GS}}, & I_{\text{D}} = 250 \ \mu\text{A} \end{array} $	Q2 Q1	1 1	1.9 1.9	3 3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 10$ mA, Referenced to 25°C $I_D = 250$ uA, Referenced to 25°C	Q2 Q1		-3.2 -4.2		mV/°C
R _{DS(on)}	Static Drain-Source		Q2		18 23 25	20 36 27	
T DS(on)	On-Resistance	$\begin{array}{ll} V_{GS} = 4.5 \ V, & I_D = 7.6 \ A \\ V_{GS} = 10 \ V, & I_D = 6.9 \ A \\ V_{GS} = 10 \ V, \ I_D = 6.9 \ A, \ T_J = 125^\circ C \\ V_{GS} = 4.5 \ V, & I_D = 6.2 \ A \end{array}$	Q1		18 23 25	20 36 27	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = 10 V$, $V_{DS} = 5 V$	Q2 Q1	30 30			А
g _{FS}	Forward Transconductance	$V_{DS} = 5 V$, $I_{D} = 8.2 A$ $V_{DS} = 5 V$, $I_{D} = 6.9 A$	Q2 Q1		25 21		S
Dynamio	Characteristics						
Ciss	Input Capacitance		Q2 Q1		570 600		pF
C _{oss}	Output Capacitance	$V_{DS} = 15 V$, $V_{GS} = 0 V$,	Q2		180		pF
C _{rss}	Reverse Transfer Capacitance	f = 1.0 MHz	Q1 Q2		150 70		pF
			Q1 Q2		70 2.8	4.9	
R _G	Gate Resistance		Q1		2.2	3.8	Ω
Switchir	ng Characteristics (Note 2)						
td(on)	Turn-On Delay Time		Q2 Q1		10 9	19 18	ns
tr	Turn-On Rise Time	$V_{DD} = 15 V, I_{D} = 1 A,$	Q2		5 4	10	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6 \Omega$	Q1 Q2		26 23	8 42 32	ns
t _f	Turn-Off Fall Time	-	Q1 Q2		3	6	ns
t _{d(on)}	Turn-On Delay Time		Q1 Q2		3	6 20	ns
t _r	Turn-On Rise Time		Q1 Q2		10 15	19 27	ns
td(off)	Turn-Off Delay Time	$V_{DD} = 15 V$, $I_D = 1 A$, $V_{GS} = 4.5 V$, $R_{GEN} = 6 \Omega$	Q1 Q2		9 16	18 29	ns
	-		Q1 Q2		14 6	25 12	
t _f	Turn-Off Fall Time		Q1		4	8	ns

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Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Switchir	ng Characteristics (Note 2)		-				
Q _{g(TOT)}	Total Gate Charge at Vgs=10V	Q2: V _{DS} = 15 V, I _D = 8.2A	Q2 Q1		10 11	15 15	nC
Qg	Total Gate Charge at Vgs=5V	Q1: V _{DS} = 15 V, I _D = 6.9A	Q2 Q1		5.8 6.1	8.2 8.5	nC
Q _{gs}	Gate-Source Charge		Q2 Q1		1.6 1.7		nC
Q _{gd}	Gate–Drain Charge		Q2 Q1		2.1 2.2		nC
Drain–S	ource Diode Characteris	tics and Maximum Rating	s				
ls	Maximum Continuous Drain-Sc	ource Diode Forward Current	Q2 Q1			2.3 1.3	А
Trr	Reverse Recovery Time	I _F = 8.2 A,	Q2		15		ns
Q _{rr}	Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A}/\mu \text{s} \qquad (\text{Note 3})$			6		nC
Trr	Reverse Recovery Time	I _F = 6.9 A,	Q1		19		ns
Q _{rr}	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu \text{s} \qquad (\text{Note 3})$			10		nC
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 2.3 A$ (Note 2) $V_{GS} = 0 V, I_S = 5 A$ (Note 2)	Q2 Q2		0.6 0.7	0.7 1.0	V

Notes:

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{_{\theta JC}}$ is guaranteed by design while $R_{_{\theta CA}}$ is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in² pad of 2 oz copper

c) 135°C/W when mounted on a minimum pad.

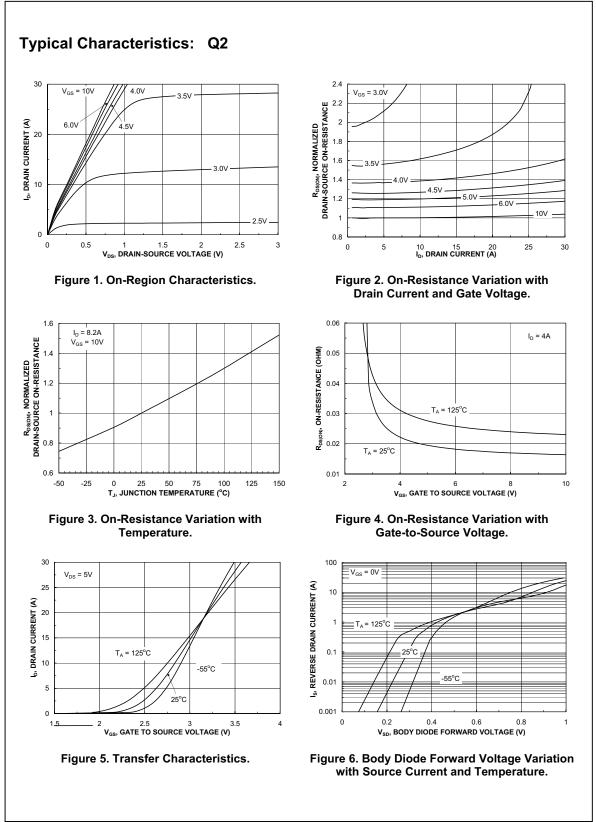
Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

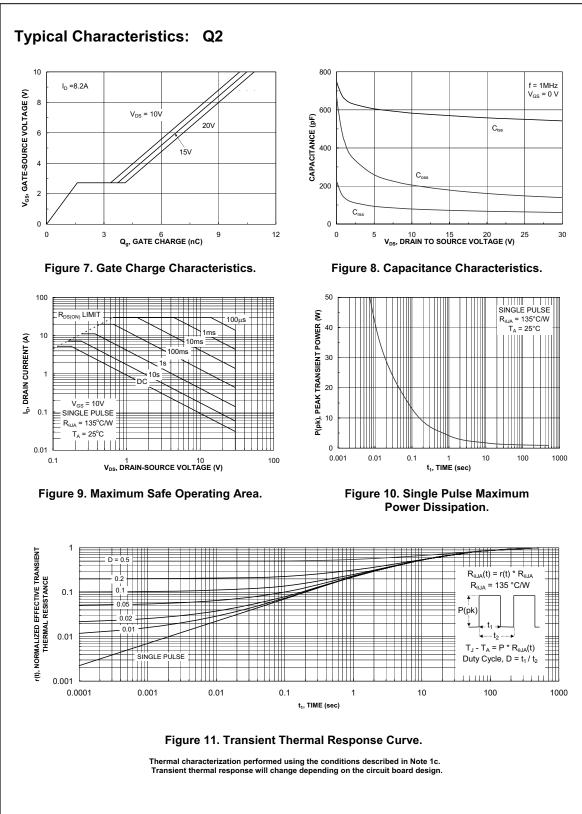
3. See "SyncFET Schottky body diode characteristics" below.

4. MT4914 is a lead free product. The MT4914 marking will appear on the reel label.

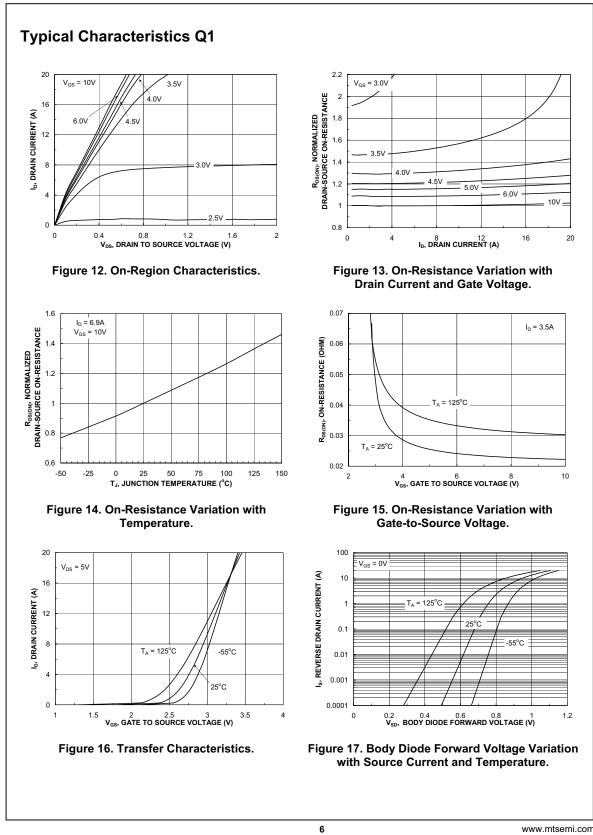
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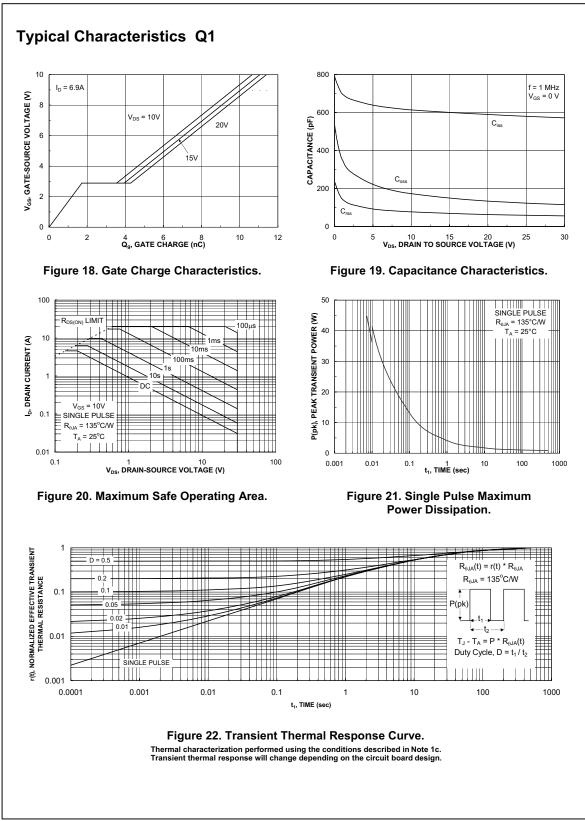






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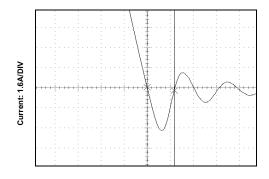


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Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

Mos-tech's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. **Figure 23** shows the reverse recovery characteristic of the MT4914.



Time: 10nS/DIV

Figure 23. MT4914 SyncFET body diode reverse recovery characteristic.

For comparison purposes, **Figure 24** shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (MT4914).

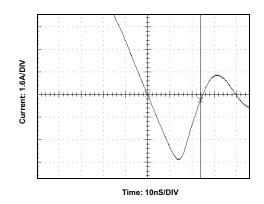
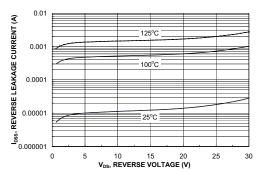
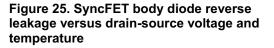
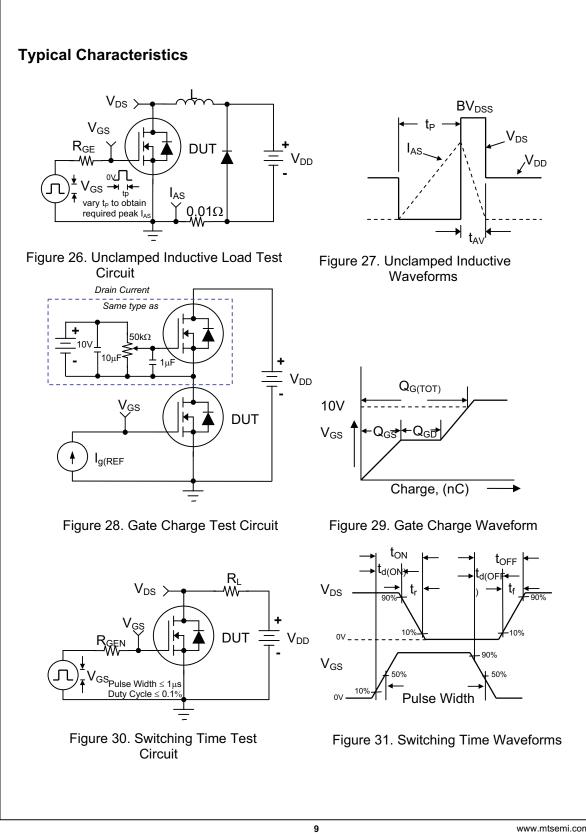


Figure 24. Non-SyncFET (MT4914) body diode reverse recovery characteristic.

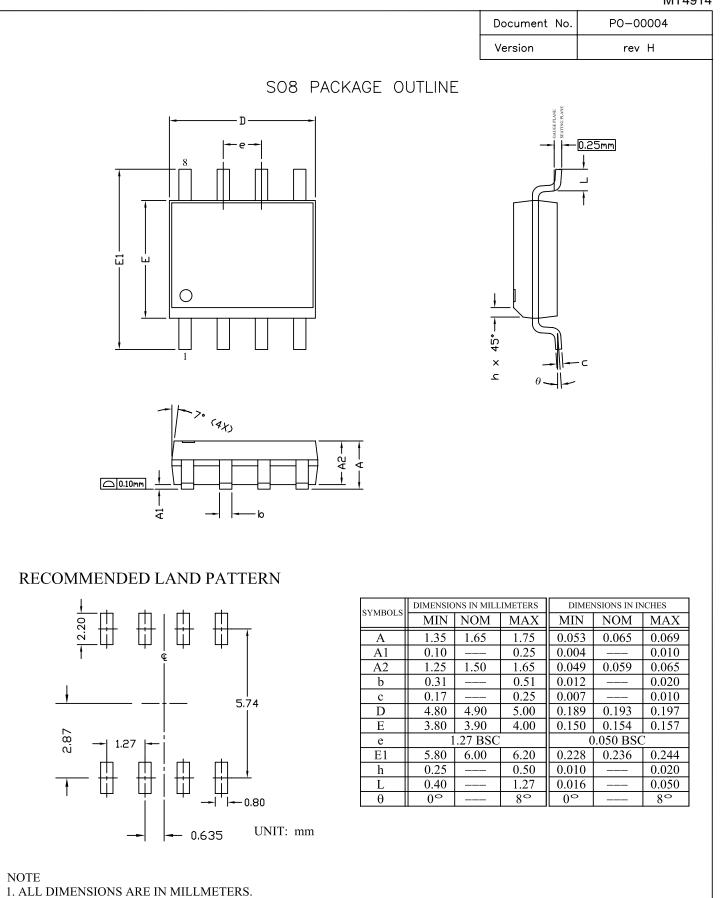
Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.







MT4914



- 2. DIMENSIONS ARE IN MILLMETERS.
- 3. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 4. DIMENSION L IS MEASURED IN GAUGE PLANE.
- 5. CONTROLLING DIMENSION IS MILLIMETER.
- CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

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